

Notice of References Cited	Application/Control No. 09/911,268	Applicant(s)/Patent Under Reexamination ECKEL ET AL.	
	Examiner Tae H. Yoon	Art Unit 1796	Page 1 of 1

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*	C	US-7,067,567	06-2006	Seidel et al.	523/201
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*	E	US-6,828,366	12-2004	Seidel et al.	524/127
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NON-PATENT DOCUMENTS

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